Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er	
10/075,016	ASANO, TOMOYUKI	ASANO, TOMOYUKI	
Examiner	Art Unit		
Longbit Chai	2131		

	SEARCHED					
Class	Subclass	Date	Examiner			
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3801	201-203		DBC			
	297-282	- ',	ZB(			
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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